

## Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness
- Resistant to Latch-Up
- Halogen Free, RoHS Compliant

## Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

## Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- LED Lighting Power Supplies

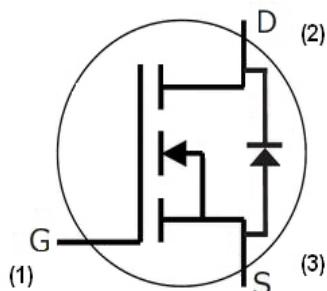
Part Number	Package	Marking
GC2M0160120D	TO-247-3	GC2M0160120

<b>V<sub>DS</sub></b>	1200 V
<b>I<sub>D</sub> @ 25°C</b>	18 A
<b>R<sub>DS(on)</sub></b>	160 mΩ



TO-247-3

## Package



## Maximum Ratings ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DS\max}$	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{GS\max}$	Gate - Source Voltage	-10/+25	V	Absolute maximum values	
$V_{GSop}$	Gate - Source Voltage	-5/+20	V	Recommended operational values	
$I_D$	Continuous Drain Current	18	A	$V_{GS} = 20 \text{ V}, T_c = 25^\circ\text{C}$	Fig. 19
		12		$V_{GS} = 20 \text{ V}, T_c = 100^\circ\text{C}$	
$I_{D(\text{pulse})}$	Pulsed Drain Current	40	A	Pulse width $t_p$ limited by $T_{j\max}$	Fig. 22
$P_D$	Power Dissipation	125	W	$T_c = 25^\circ\text{C}, T_j = 150^\circ\text{C}$	Fig. 20
$T_J, T_{stg}$	Operating Junction and Storage Temperature	-55 to +150	°C		
$T_L$	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
$M_d$	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	

### Electrical Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	2.9	4	V	$V_{DS} = V_{GS}, I_{DS} = 2.5 \text{ mA}$	Fig. 11
			2.4		V	$V_{DS} = V_{GS}, I_{DS} = 2.5 \text{ mA}, T_J = 150^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current		1	100	$\mu\text{A}$	$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}$	
$I_{GSS}$	Gate-Source Leakage Current			250	nA	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	
$R_{DS(\text{on})}$	Drain-Source On-State Resistance	160	196		$\text{m}\Omega$	$V_{GS} = 20 \text{ V}, I_D = 10 \text{ A}$	Fig. 4, 5, 6
		290				$V_{GS} = 20 \text{ V}, I_D = 10 \text{ A}, T_J = 150^\circ\text{C}$	
$g_{fs}$	Transconductance		3.8		S	$V_{DS} = 20 \text{ V}, I_{DS} = 10 \text{ A}$	Fig. 7
			5.3			$V_{DS} = 20 \text{ V}, I_{DS} = 10 \text{ A}, T_J = 150^\circ\text{C}$	
$C_{iss}$	Input Capacitance		606		pF	$V_{GS} = 0 \text{ V}$	Fig. 17, 18
$C_{oss}$	Output Capacitance		55			$V_{DS} = 1000 \text{ V}$	
$C_{rss}$	Reverse Transfer Capacitance		5			$f = 1 \text{ MHz}$	
$E_{oss}$	$C_{oss}$ Stored Energy		28			$V_{AC} = 25 \text{ mV}$	
$E_{AS}$	Avalanche Energy, Single Pulse		600		mJ	$I_D = 10 \text{ A}, V_{DD} = 50 \text{ V}$	Fig. 29
$E_{ON}$	Turn-On Switching Energy		121		$\mu\text{J}$	$V_{DS} = 800 \text{ V}, V_{GS} = -5/20 \text{ V}, I_D = 10 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega, L = 434 \mu\text{H}$	Fig. 25
$E_{OFF}$	Turn Off Switching Energy		48				
$t_{d(on)}$	Turn-On Delay Time		7		ns	$V_{DD} = 800 \text{ V}, V_{GS} = -5/20 \text{ V}$ $I_D = 10 \text{ A}$ $R_{G(\text{ext})} = 2.5 \Omega, R_L = 80 \Omega$ Timing relative to $V_{DS}$ Per IEC60747-8-4 pg 83	Fig. 27
$t_r$	Rise Time		9				
$t_{d(off)}$	Turn-Off Delay Time		13				
$t_f$	Fall Time		14				
$R_{G(\text{int})}$	Internal Gate Resistance		6.5		$\Omega$	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$	
$Q_{gs}$	Gate to Source Charge		11		nC	$V_{DS} = 800 \text{ V}, V_{GS} = -5/20 \text{ V}$ $I_D = 10 \text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12
$Q_{gd}$	Gate to Drain Charge		17				
$Q_g$	Total Gate Charge		40				

### Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$V_{SD}$	Diode Forward Voltage	3.9		V	$V_{GS} = -5 \text{ V}, I_F = 5 \text{ A}$	Fig. 8, 9, 10
		3.5			$V_{GS} = -5 \text{ V}, I_F = 5 \text{ A}, T_J = 150^\circ\text{C}$	
$I_S$	Continuous Diode Forward Current		25	A	$T_c = 25^\circ\text{C}$	Note 1
$t_{rr}$	Reverse Recovery Time	20		ns	$V_{GS} = -5 \text{ V}, I_{SD} = 10 \text{ A}, V_R = 800 \text{ V}$ dif/dt = 2400 A/ $\mu\text{s}$	Note 1
$Q_{rr}$	Reverse Recovery Charge	192		nC		
$I_{rrm}$	Peak Reverse Recovery Current	16		A		

Note (1): When using SiC Body Diode the maximum recommended  $V_{GS} = -5 \text{ V}$

### Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{iJC}$	Thermal Resistance from Junction to Case	0.9	1.0	K/W		Fig. 21
$R_{iJA}$	Thermal Resistance From Junction to Ambient		40			

## Typical Performance

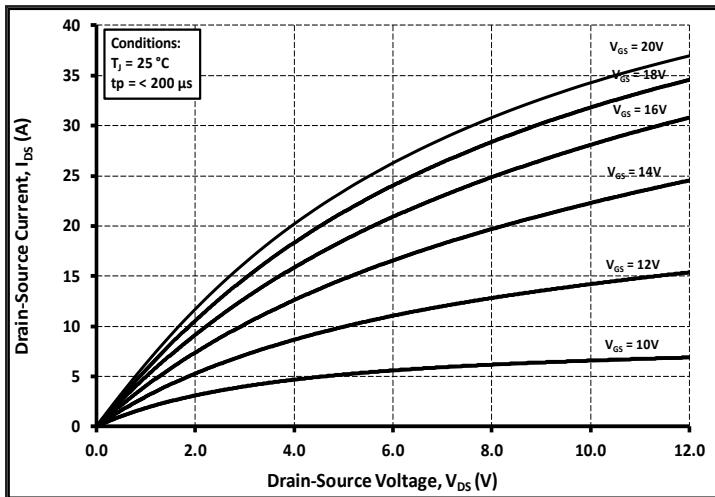
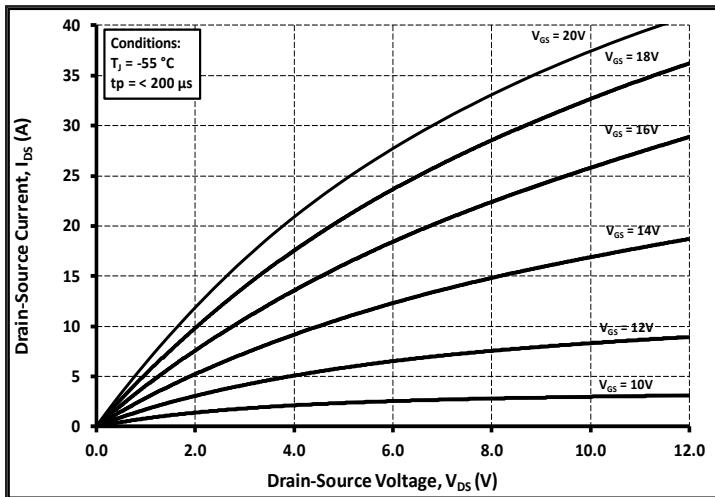


Figure 1. Output Characteristics  $T_J = -55\text{ }^{\circ}\text{C}$

Figure 2. Output Characteristics  $T_J = 25\text{ }^{\circ}\text{C}$

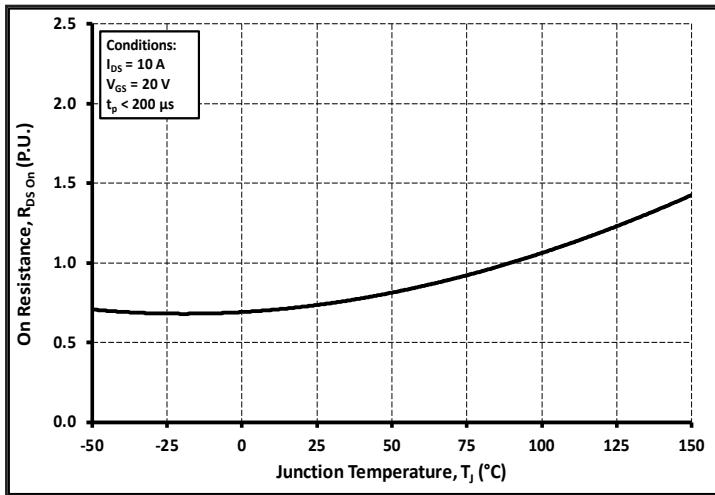
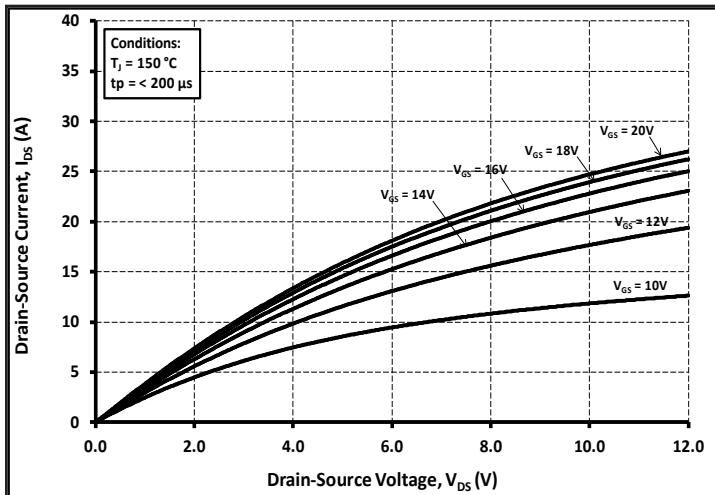


Figure 3. Output Characteristics  $T_J = 150\text{ }^{\circ}\text{C}$

Figure 4. Normalized On-Resistance vs. Temperature

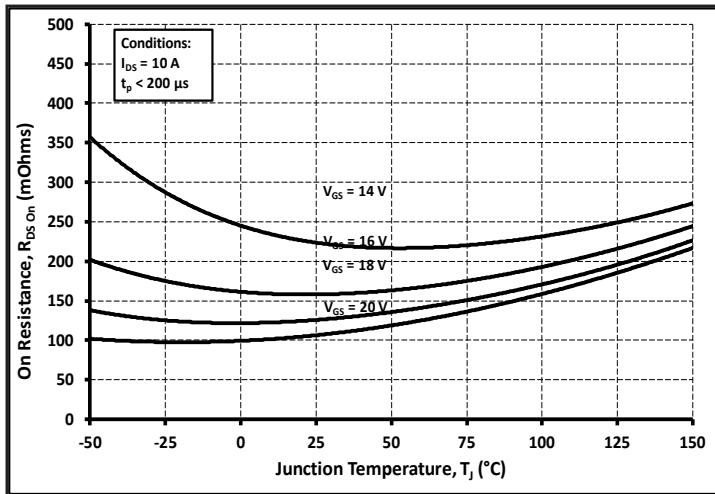
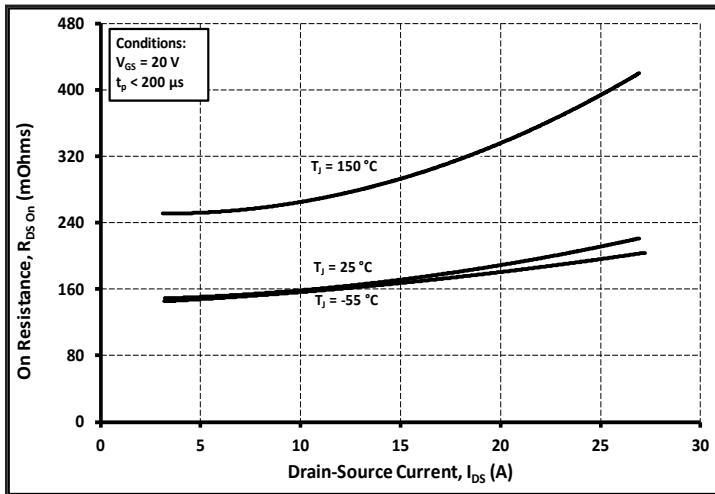


Figure 5. On-Resistance vs. Drain Current  
For Various Temperatures

Figure 6. On-Resistance vs. Temperature  
For Various Gate Voltage

## Typical Performance

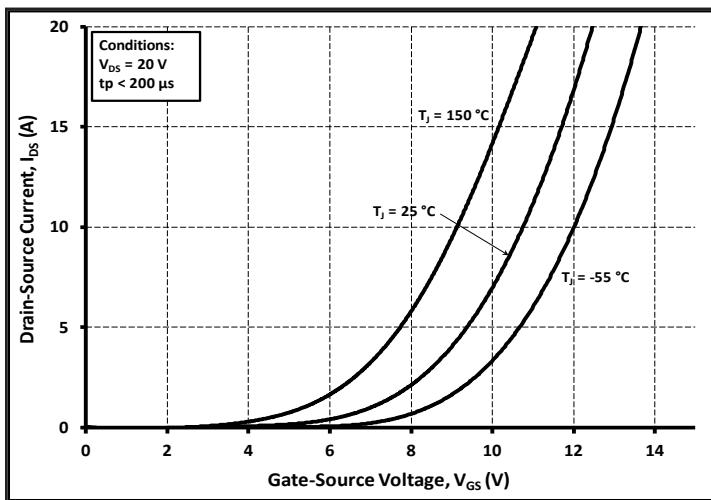


Figure 7. Transfer Characteristic for Various Junction Temperatures

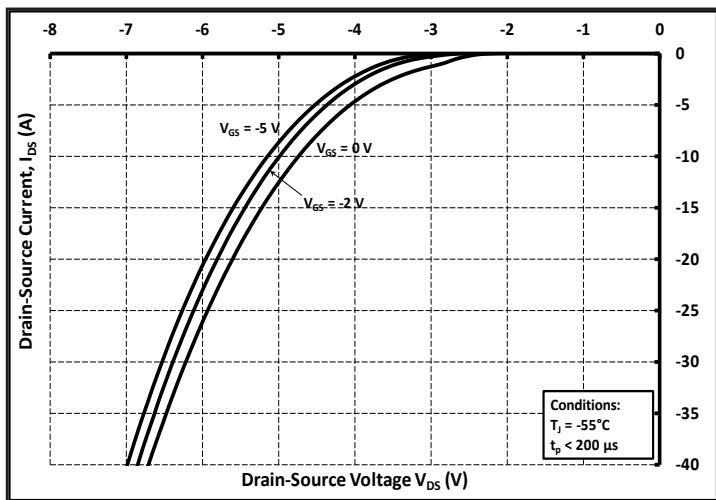


Figure 8. Body Diode Characteristic at  $-55^\circ\text{C}$

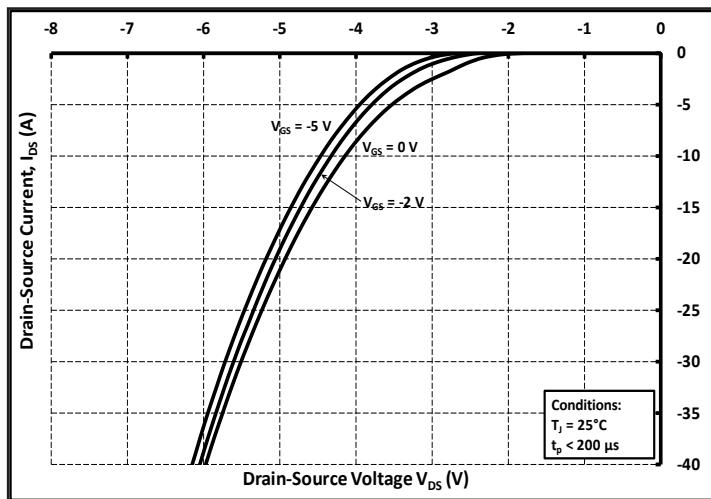


Figure 9. Body Diode Characteristic at  $25^\circ\text{C}$

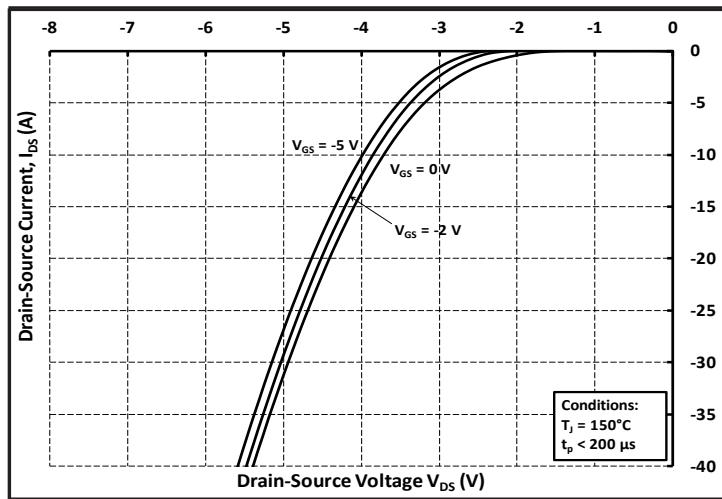


Figure 10. Body Diode Characteristic at  $150^\circ\text{C}$

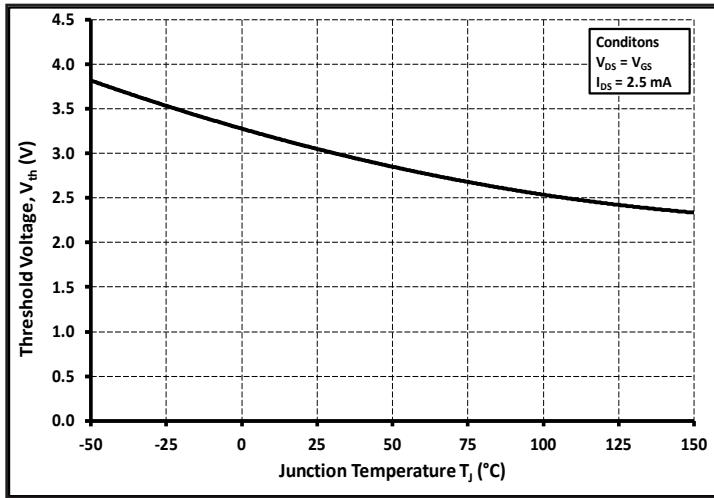


Figure 11. Threshold Voltage vs. Temperature

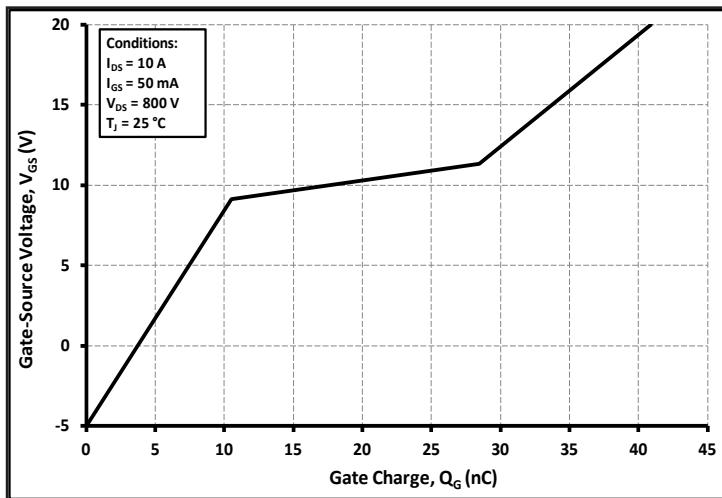


Figure 12. Gate Charge Characteristics

## Typical Performance

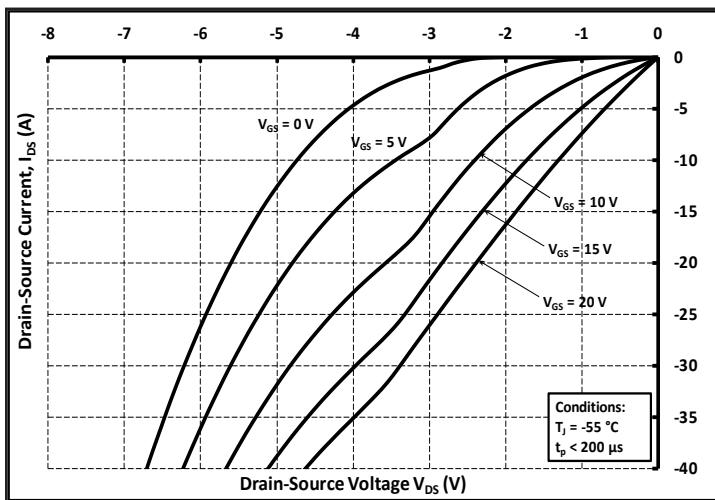


Figure 13. 3rd Quadrant Characteristic at  $-55\text{ }^\circ\text{C}$

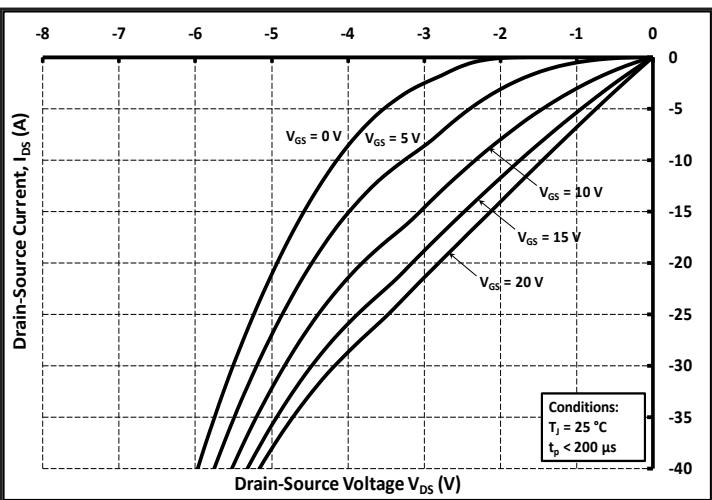


Figure 14. 3rd Quadrant Characteristic at  $25\text{ }^\circ\text{C}$

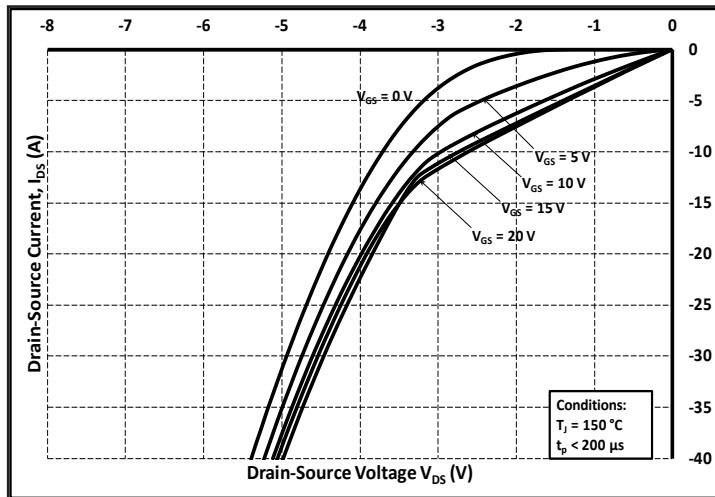


Figure 15. 3rd Quadrant Characteristic at  $150\text{ }^\circ\text{C}$

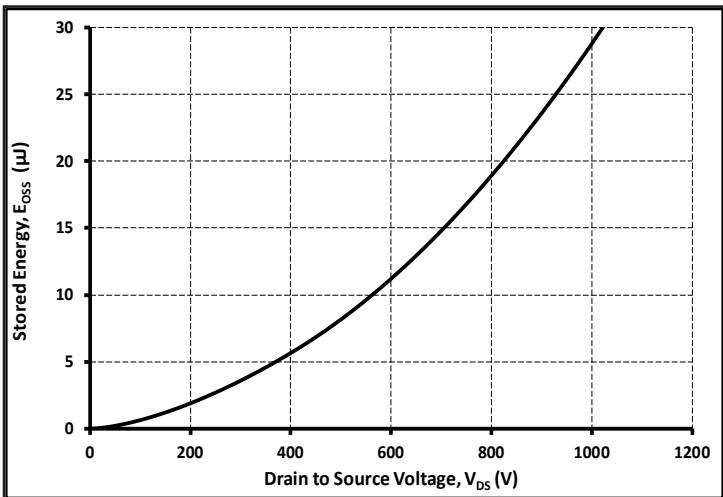


Figure 16. Output Capacitor Stored Energy

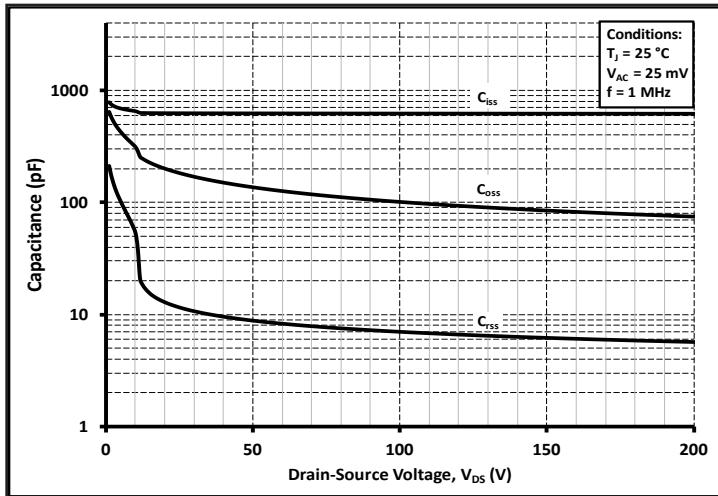


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

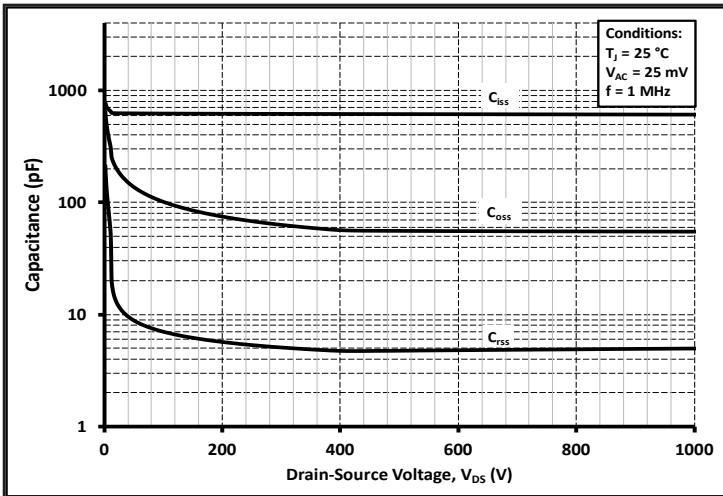


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

### Typical Performance

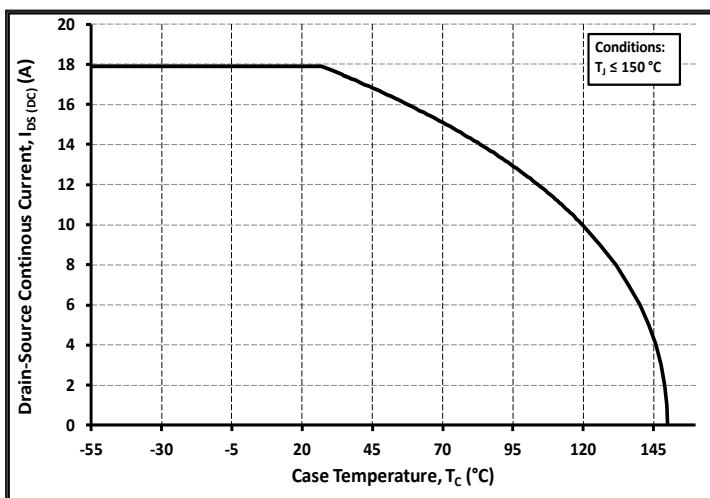


Figure 19. Continuous Drain Current Derating vs.  
Case Temperature

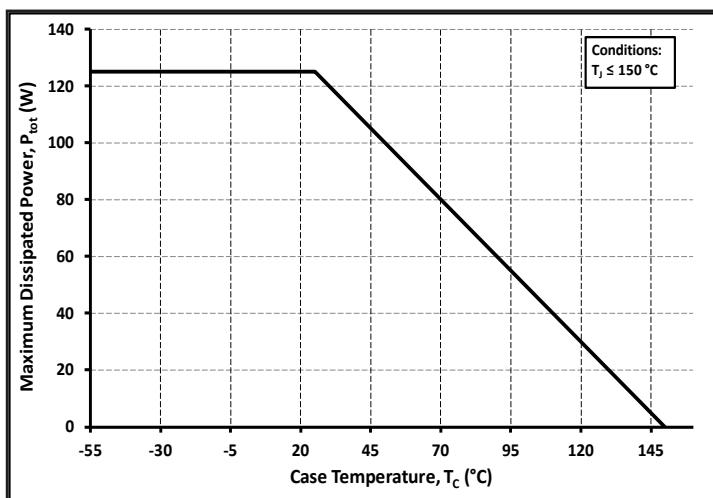


Figure 20. Maximum Power Dissipation Derating vs.  
Case Temperature

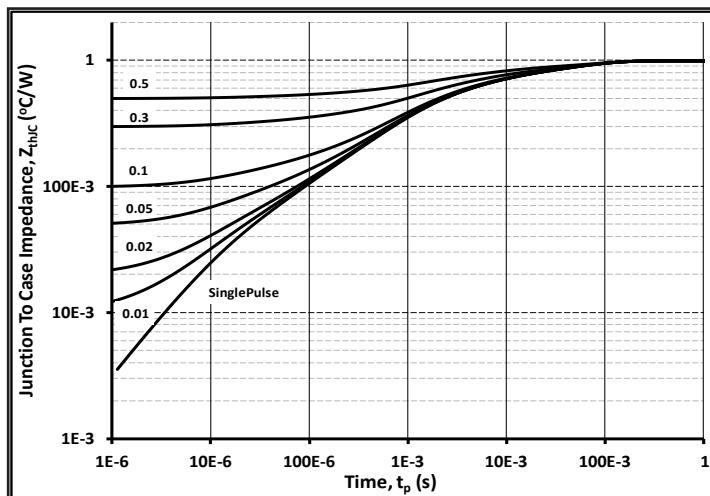


Figure 21. Transient Thermal Impedance  
(Junction - Case)

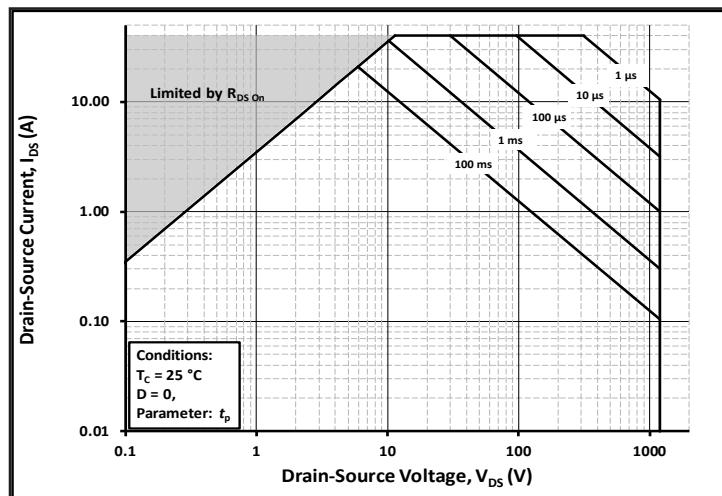


Figure 22. Safe Operating Area

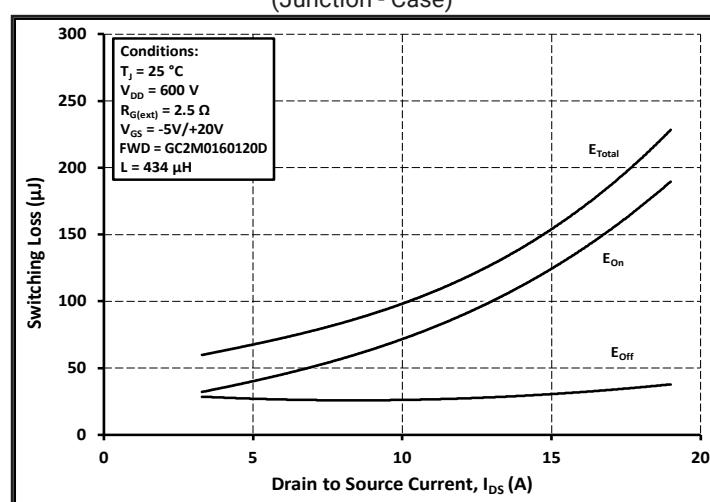


Figure 23. Clamped Inductive Switching Energy vs.  
Drain Current ( $V_{DS} = 600$  V)

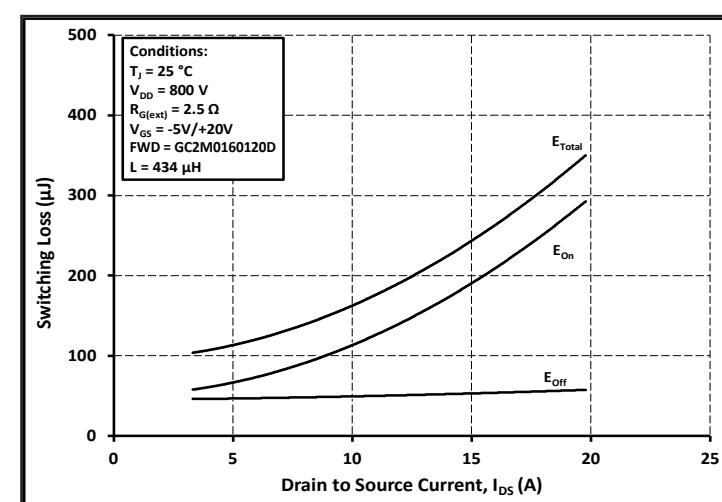


Figure 24. Clamped Inductive Switching Energy vs.  
Drain Current ( $V_{DS} = 800$  V)

## Typical Performance

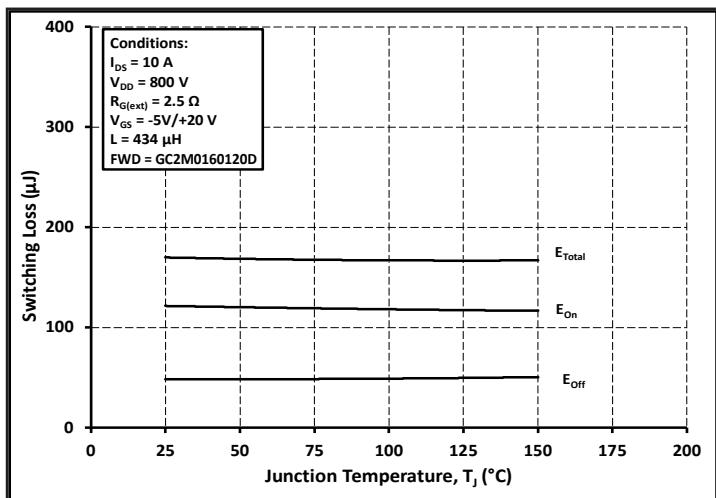
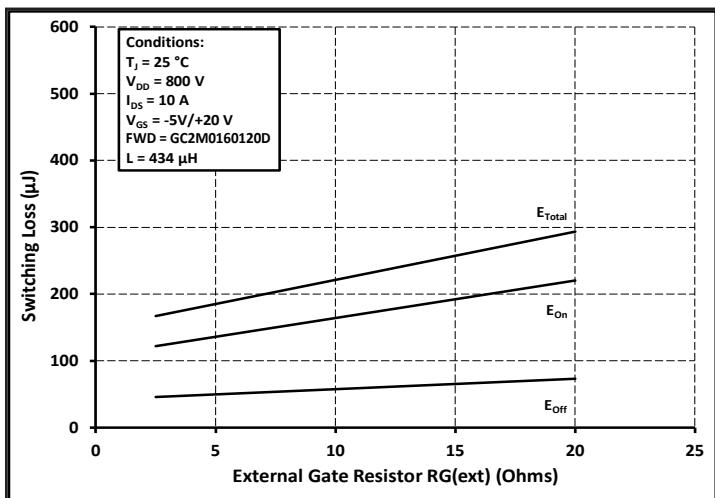


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(\text{ext})}$

Figure 26. Clamped Inductive Switching Energy vs. Temperature

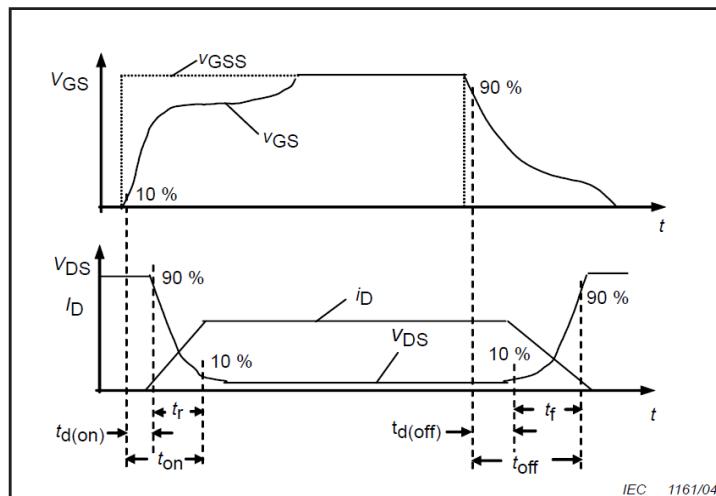
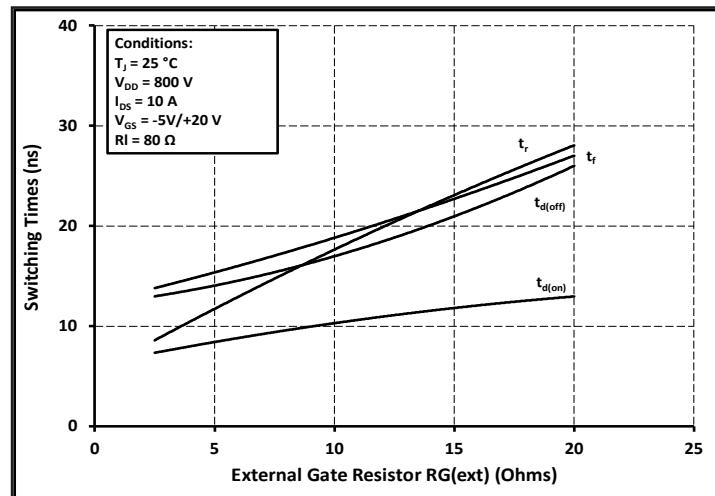


Figure 27. Switching Times vs.  $R_{G(\text{ext})}$

Figure 28. Switching Times Definition

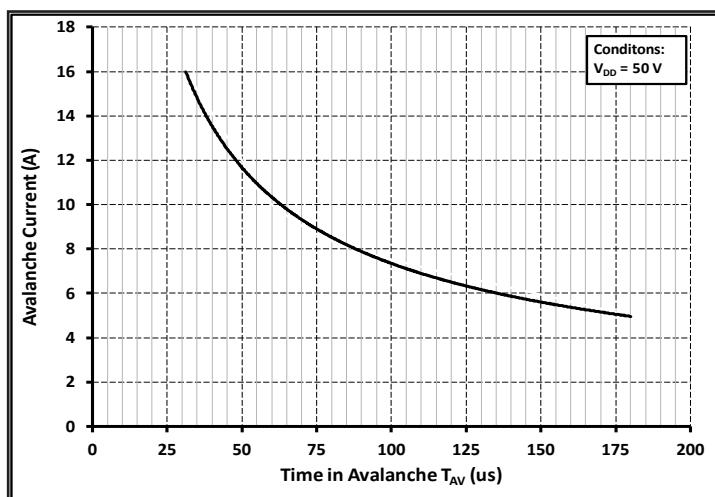


Figure 29. Single Avalanche SOA curve

### Test Circuit Schematic

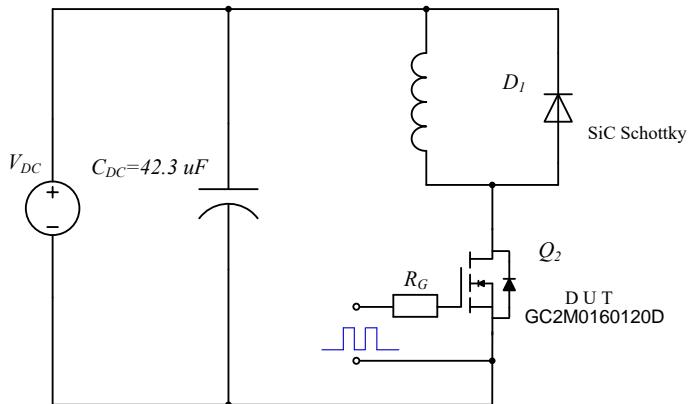


Figure 30. Clamped Inductive Switching Waveform Test Circuit

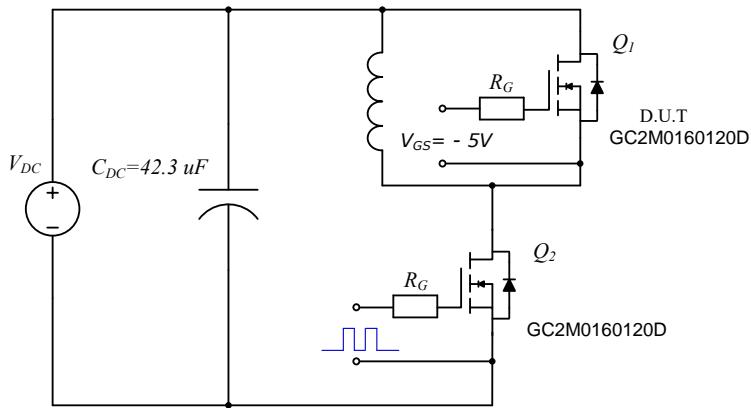


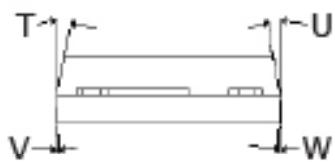
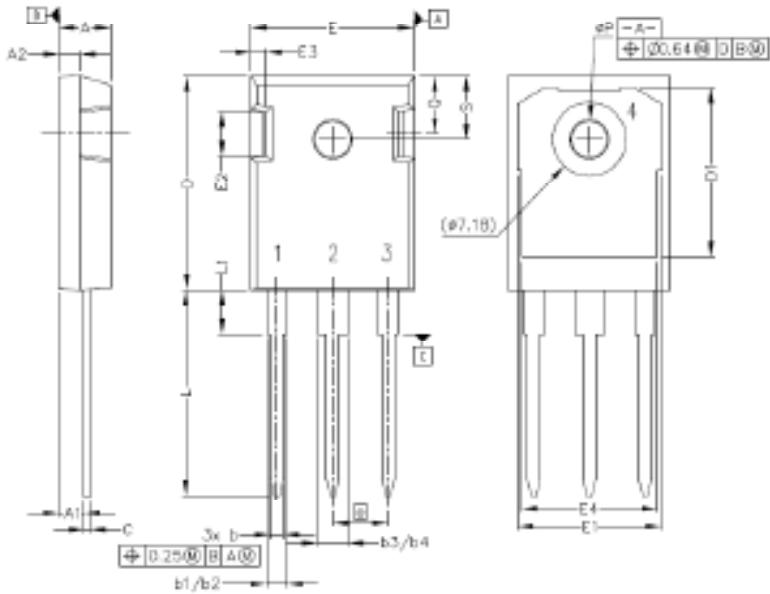
Figure 31. Body Diode Recovery Test Circuit

### ESD Ratings

ESD Test	Total Devices Sampled	Resulting Classification
ESD-HBM	All Devices Passed 1000V	2 (>2000V)
ESD-MM	All Devices Passed 400V	C (>400V)
ESD-CDM	All Devices Passed 1000V	IV (>1000V)

## Package Dimensions

### Package TO-247-3

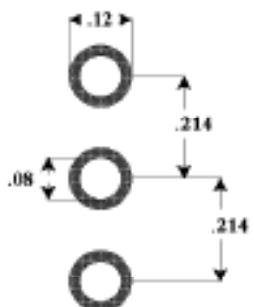


### Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

POS	Inches		Millimeters	
	Min	Max	Min	Max
A	.190	.205	4.89	5.21
A1	.090	.100	2.29	2.54
A2	.075	.095	1.91	2.16
B	.042	.052	1.07	1.33
B1	.075	.095	1.91	2.41
B2	.075	.095	1.91	2.16
B3	.113	.130	2.87	3.30
B4	.113	.129	2.87	3.13
C	.022	.027	0.55	0.68
D	.019	.031	20.00	21.10
D1	.040	.095	16.25	17.65
D2	.037	.049	9.95	11.25
E	.620	.635	15.75	16.13
E1	.516	.557	13.10	14.15
E2	.145	.201	3.68	5.18
E3	.039	.075	1.00	1.90
E4	.467	.529	12.36	13.43
*	.214 BSC		5.44 BSC	
N	3		3	
L	.760	.800	19.01	20.32
L1	.161	.173	4.10	4.40
MP	.138	.144	3.51	3.65
Q	.216	.236	5.49	6.00
S	.238	.248	6.04	6.38
T	9°	11°	9°	11°
U	9°	11°	9°	11°
V	2"	0"	2"	0"
W	2"	0"	2"	0"

### Recommended Solder Pad Layout



TO-247-3

Part Number	Package
GC2M0160120D	TO-247-3

单击下面可查看定价，库存，交付和生命周期等信息

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